

VRRM	= 650 V
IF (TC=135 °C)	= 8.8 A
QC	= 30 nC

Description

Homogeneous-current SiC Schottky diode with low VF, high repetitive surge current, low leakage, no reverse or forward recovery, and high-temperature operation.



Features

- Temperature-independent fast switching
- Low reverse leakage current
- Low VF at high temperatures
- Easy paralleling (positive temperature coefficient of VF)
- Essentially no switching losses
- Subject to AEC-Q101 qualification
- High repetitive surge current

Typical Applications

- High-frequency power converters
- Industrial motor drives
- Switch-mode power supplies
- Electric vehicles and battery chargers
- Solar inverters
- Power factor correction
- Free-wheeling diode

Part Number	Package	Marking
QSD6HCS65U	TO220	Q



Maximum Rated Values (TC=25°C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note	
VRRM	Repetitive Peak Reverse Voltage	650	V			
VR	DC Peak Reverse Voltage	650	V			
		21		TC=25°C		
IF	Continuous Forward Current	8.8	А	TC=135°C	Fig. 3	
		7.0		Tc=150°C		
TEDM	Repetitive Peak Forward Surge Cur-	26	Δ	TC=25°C, tP=10 ms, Half Sine Pulse		
IFRM	rent	22	A	TC=110°C, tP=10 ms, Half Sine Pulse		
IFSM	Non-Repetitive Forward Surge Cur- rent	34	A	TC=25°C, tP=10 ms, Half Sine Pulse		
		27		TC=110°C, tP=10 ms, Half Sine Pulse		
TEMAY	Non-Repetitive Forward Surge Cur-	424	A	TC=25°C, tP=10µs, Square Wave Pulse		
IF,™AX	rent	400		TC=110°C, tP=10µs, Square Wave Pulse		
Dtot	Power Dissipation	65	14/	TC=25°C	Fig. 4	
Plot	Power Dissipation	28	vv	TC=110°C	гiy. 4	
נד	Operating Temperature	-55 to +175	°C			
Tstg	Storage Temperature	-55 to +175	°C			
	TO-247 Mounting Torque	1 8.8	Nm Ibf-in	M3 Screw 6-32 Screw		



Electrical Characteristics (TJ=25°C)

Symbol	Parameter	Value Min.	Unit Typ.	Test Conditions Max.	Note			
VF	Forward Voltago		1.4	1.6		V	IF=6A, TJ=25°C	Fig. 1
	Forward voltage		1.5	2.0	v	IF=6A, TJ=175°C	гіў. 1	
IR			0.5	15		VR=650V, TJ=25°C	Fig. 2	
	Reverse Current		6		μA	VR=650V, TJ=175°C		
QC	Total Capacitive Charge		30		nC	VR=650V,TJ=25°C	Fig. 5	
C Total Capacitance			421			VR=0V, TJ=25°C, f=1MHz	Fig. 6	
	Total Capacitance		38		pF	VR=400V, TJ=25°C, f=1MHz		
			37			VR=650V, TJ=25°C, f=1MHz		
EC	Capacitance Stored Energy		5.6		μĴ	VR=650 V	Fig. 7	

Thermal Characteristics

Symbol	Parameter	Value	Unit	Note
ReJC	Thermal Resistance(Junction to Case)	2.3	°C/W	Fig. 8



Typical Performance







Figure 4. Power Derating





Figure 5. Capacitance Charge Vs. Reverse Voltage



Figure 6. Capacitance Vs. Reverse Voltage





Figure 8. Transient Thermal Response Curve(Junction-to-Case)





Package Dimensions

Figure 1



DOC	Inc	hes	Millimeters		
P05	Min	Max	Min	Max	
А	.190	.205	4.70	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b2	.065	.094	1.65	2.39	
С	.015	.035	0.38	0.89	
D	.819	.845	20.80	21.46	
D1	.515	-	13.08	-	
D2	.020	.053	0.51	1.35	
E	.620	.640	15.49	16.26	
E1	.530	-	13.46	-	
E2	.135	.157	3.43	3.99	
е	.2	14	5.44		
ØК	.0	10	0.25		
L	.780	.800	19.81	20.32	
L1	-	.177	-	4.50	
ØP	.140	.144	3.56	3.66	
ØP1	.278	.291	7.06	7.39	
Q	.212	.244	5.38	6.20	
S	.243 6.17		17		
W	-	.006	-	0.15	



Recommended Solder Pad Layout



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